


Search Notes 	Application/Control No. 10044420	Applicant(s)/Patent Under Reexamination BERKNER ET AL.
	Examiner Hung, Yubin	Art Unit 2624

SEARCHED			
Class	Subclass	Date	Examiner
382	166,173,232,233,235,248	3/26/07	YH
348	403.1	3/26/07	YH
375	240.18,240.19	3/26/07	YH
708	203	3/26/07	YH

SEARCH NOTES		
Search Notes	Date	Examiner
EAST Text search (USPGPUB, USPAT, EPO, JPO, DERWENT, IBM-TDB)	3/26/07	YH
ACM	7/27/05	YH
SPIE	7/28/05	YH
IEEE Xplore	12/9/05	YH
Consulted with Wenpeng Chen (Claim 92)	7/26/05	YH

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
382	235,173	3/26/07	YH